October 2014

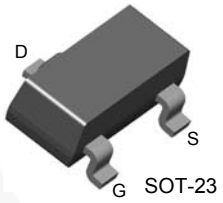
BSS123L
N-Channel Logic Level Enhancement Mode Field Effect Transistor

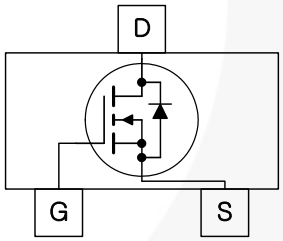
Features

- 0.17 A, 100 V, $R_{DS(ON)}$ = 6 Ω at V_{GS} = 10 V
  $R_{DS(ON)}$ = 10 Ω at V_{GS} = 4.5 V
- High Density Cell Design for Low $R_{DS(ON)}$
- Rugged and Reliable
- Compact Industry Standard SOT-23 Surface Mount Package
- Very Low Capacitance
- Fast Switching Speed

Description

This N-channel enhancement mode field effect transistor is produced using high cell density, trench MOSFET technology. This product minimizes on-state resistance while providing rugged, reliable and fast switching performance. This product is particularly suited for low-voltage, low-current applications such as small servo motor control, power MOSFET gate drivers, logic level transistor, high speed line drivers, power management/power supply and switching applications.





Ordering Information

Part Number	Marking	Package	Packing Method
BSS123L	SB	SOT-23 3L	Tape and Reel

Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only. Values are at T_A = 25°C unless otherwise noted.

Symbol	Parameter		Value	Unit
V_{DSS}	Drain-Source Voltage		100	V
V_{GSS}	Gate-Source Voltage		±20	V
I_D	Maximum Drain Current	Continuous	0.17	A
		Pulsed	0.68	
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +150	°C
T_L	Maximum Lead Temperature for Soldering Purposes, 1/16 inch from Case for 10 Seconds		300	°C

Thermal Characteristics

Values are at T_A = 25°C unless otherwise noted.

Symbol	Parameter	Value	Unit
P_D	Maximum Power Dissipation(1)	0.36	W
	Derate Above 25°C	2.8	mW/°C
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient(1)	380	°C/W

Note:

1. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.

a) 380°C/W when mounted on a minimum pad.

Scale 1: 1 on letter size paper

ESD Rating(2)

Symbol	Parameter	Value	Unit
HBM	Human Body Model per ANSI/ESDA/JEDEC JS-001-2012	50	V
CDM	Charged Device Model per JEDEC C101C	>2000	

Note:

2. ESD values are in typical, no over-voltage rating is implied, ESD CDM zap voltage is 2000 V maximum.

Electrical Characteristics

Values are at T_A = 25°C unless otherwise noted.

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0 V, I_D = 250 μA	100	103		V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, Referenced to 25°C		100		mV/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 100 V, V_{GS} = 0 V		0.027	1	μA
		V_{DS} = 100 V, V_{GS} = 0 V, T_J = 125°C		0.159	60	
		V_{DS} = 20 V, V_{GS} = 0 V		0.07	10	nA
I_{GSSF}	Gate-Body Leakage, Forward	V_{GS} = 20 V, V_{DS} = 0 V		0.036	50	nA
I_{GSSR}	Gate-Body Leakage, Reverse	V_{GS} = -20 V, V_{DS} = 0 V		-0.019	-50	
On Characteristics(3)						
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 1 mA	0.8	1.405	2	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = 1 mA, Referenced to 25°C		-2.82		mV/°C
$R_{DS(ON)}$	Static Drain-Source On-Resistance	V_{GS} = 10 V, I_D = 0.17 A		2.98	6	Ω
		V_{GS} = 4.5 V, I_D = 0.17 A		3.17	10	
		V_{GS} = 10 V, I_D = 0.17 A, T_J = 125°C		5.63	12	
$I_{D(ON)}$	On-State Drain Current	V_{GS} = 10 V, V_{DS} = 5 V	0.680	0.735		A
g_{FS}	Forward Transconductance	V_{DS} = 10 V, I_D = 0.17 A	0.08	2.13		S
Dynamic Characteristics						
C_{iss}	Input Capacitance	V_{DS} = 25 V, V_{GS} = 0 V, f = 1.0 MHz		21.5		pF
C_{oss}	Output Capacitance			3.52		pF
C_{rss}	Reverse Transfer Capacitance			1.67		pF
R_G	Gate Resistance	V_{GS} = 15 V, V_{GS} = 1.0 MHz		7.18		Ω
Switching Characteristics(3)						
$t_{d(on)}$	Turn-On Delay	V_{DD} = 30 V, I_D = 0.28 A, V_{GS} = 10 V, R_{GEN} = 6 Ω		2.2	3.4	ns
t_r	Turn-On Rise Time			1.7	18	ns
$t_{d(off)}$	Turn-Off Delay			5.9	31	ns
t_f	Turn-Off Fall Time			5.6	5	ns
Q_g	Total Gate Charge	V_{DS} = 25 V, I_D = 0.22 A, V_{GS} = 10 V		0.793	2.5	nC
Q_{gs}	Gate-Source Charge			0.092		nC
Q_{gd}	Gate-Drain Charge			0.171		nC
Drain-Source Diode Characteristics and Maximum Ratings						
V_{SD}	Drain-Source Diode Forward Voltage	V_{GS} = 0 V, I_S = 440 mA(1)		0.867	1.3	V
T_{rr}	Diode Reverse Recovery Time	I_F = 0.2 A, diF/dt = 100 A/μS		11.9		ns
Qrr	Diode Reverse Recovery Charge			1.3		nC

Note:

3. Pulse test: pulse width ≤ 300 μs, duty cycle ≤ 2.0%.

Typical Performance Characteristics

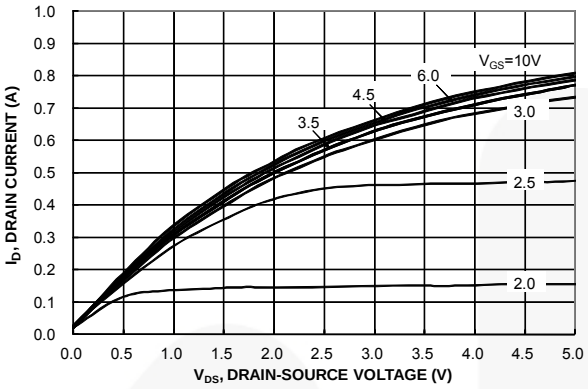


Figure 1. On-Region Characteristics

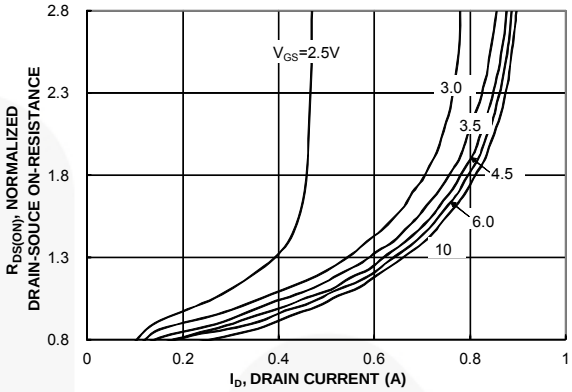


Figure 2. On-Resistance Variation with Gate Voltage and Drain Current

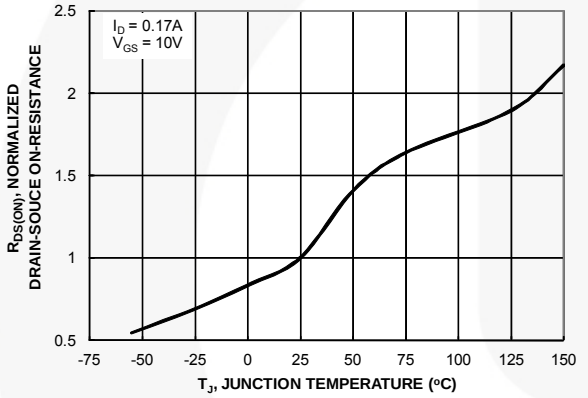


Figure 3. On-Resistance Variation with Temperature

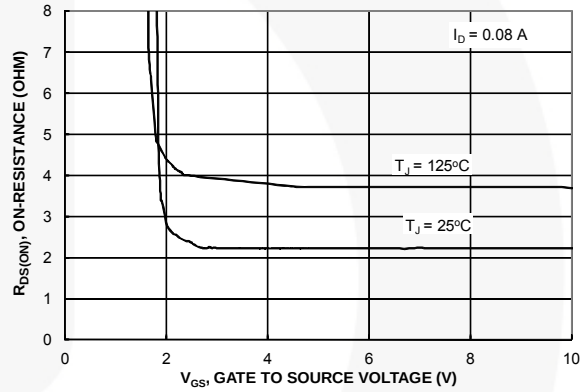


Figure 4. On-Resistance Variation with Gate-to-Source Voltage

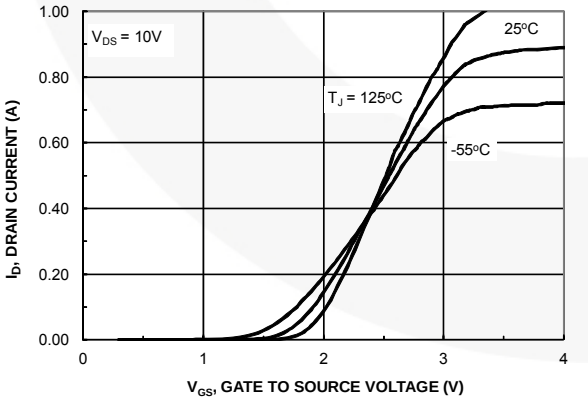


Figure 5. Transfer Characteristics

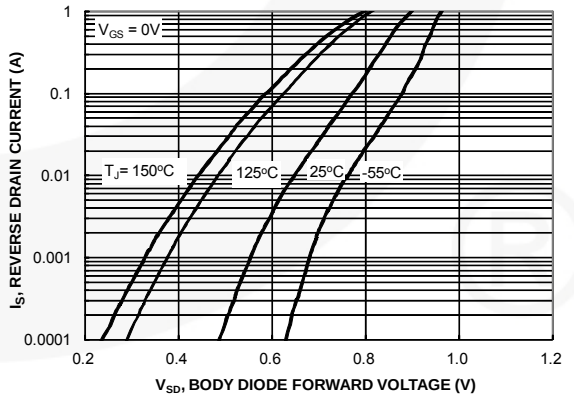


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature

Typical Performance Characteristics (Continued)

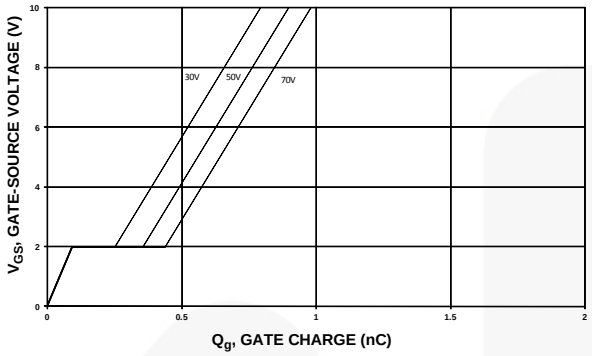


Figure 7. Gate Charge Characteristics

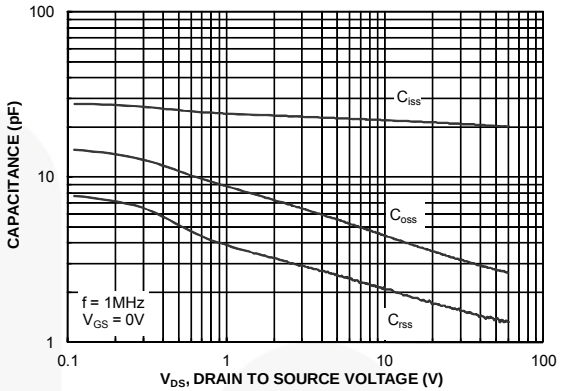


Figure 8. Capacitance Characteristics

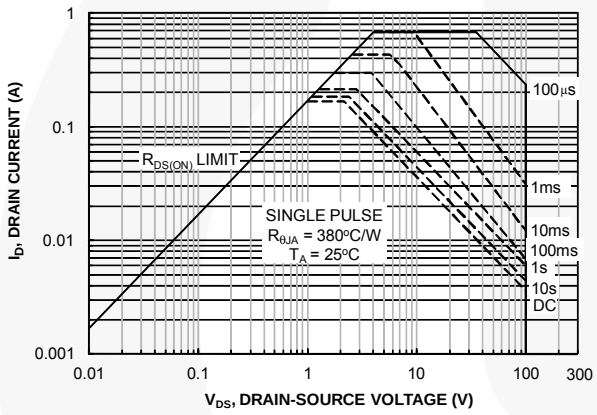


Figure 9. Maximum Safe Operating Area

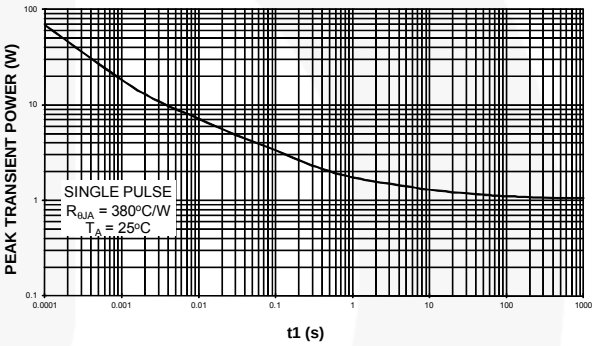


Figure 10. Single Pulse Maximum Power Dissipation

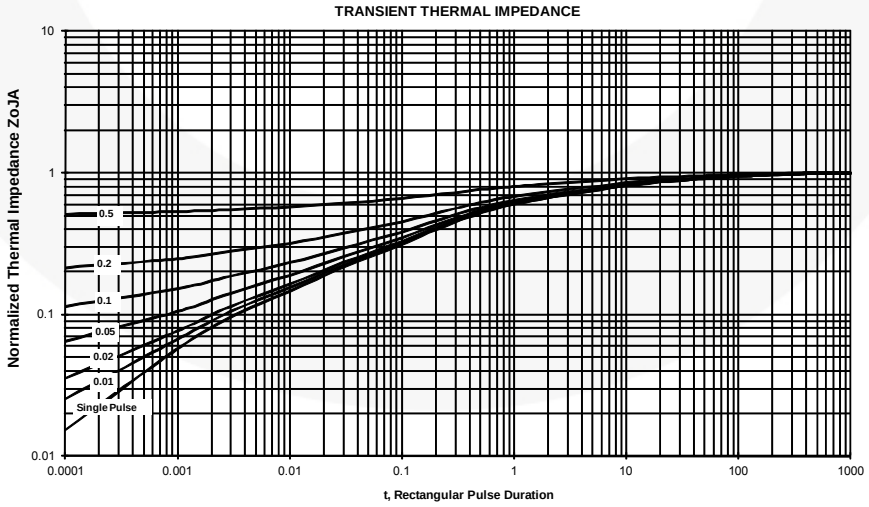
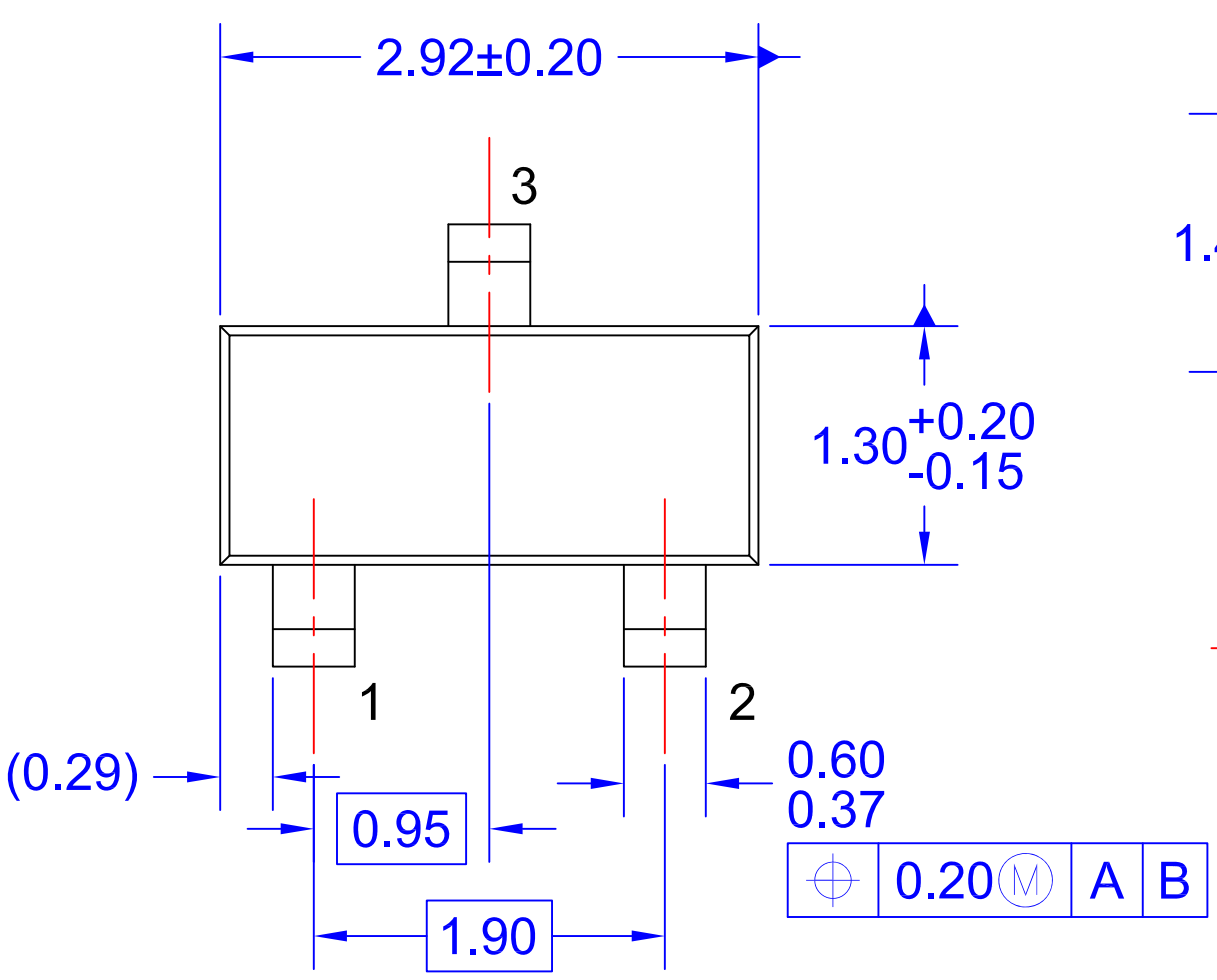
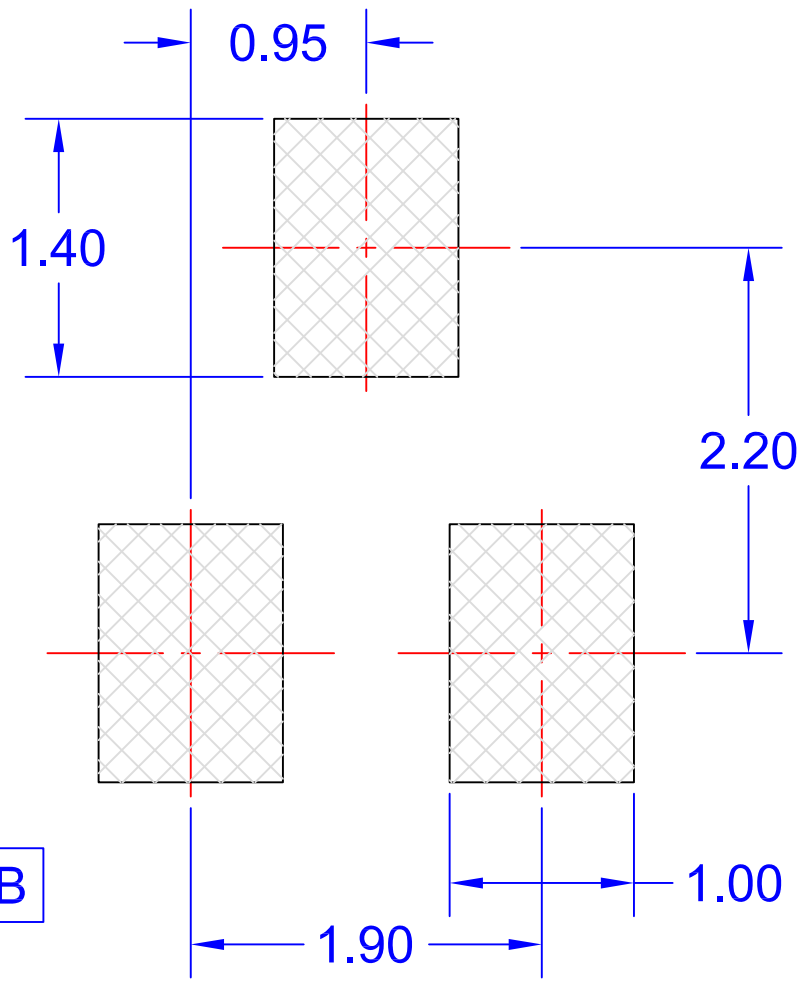
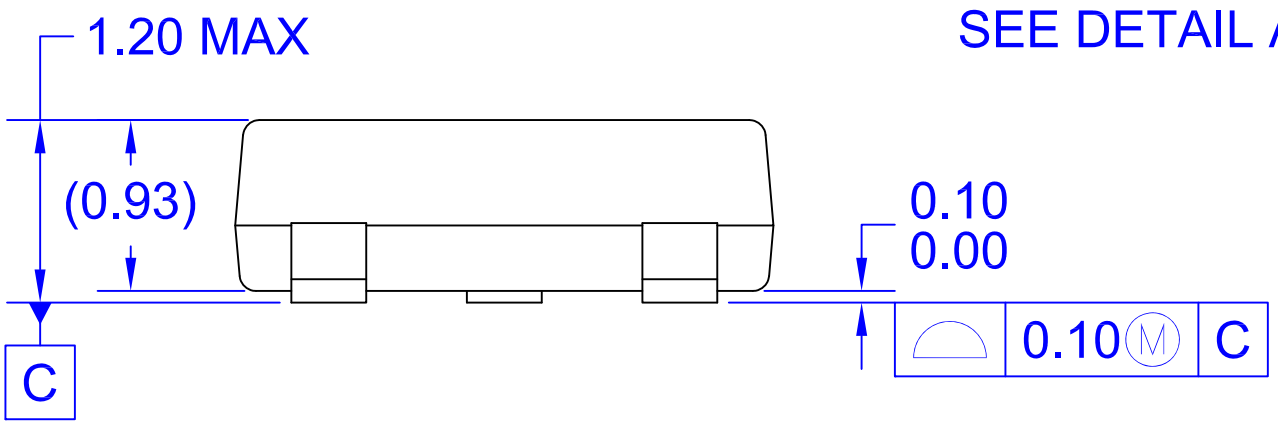


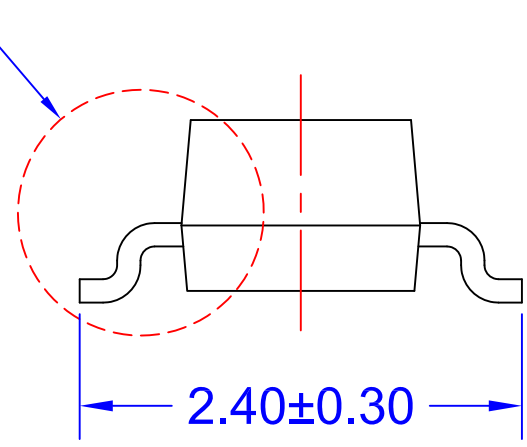
Figure 11. Transient Thermal Response Curve.

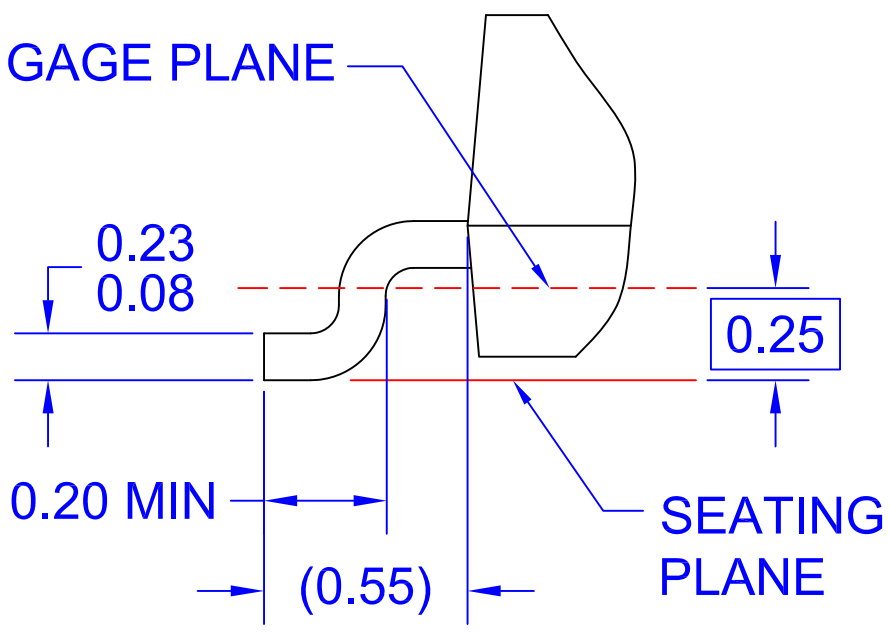




LAND PATTERN
RECOMMENDATION







DETAIL A
SCALE: 2X

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